


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574100	<b>Applicant(s)/Patent Under Reexamination</b>  TANABE, TAKAHISA
	<b>Examiner</b>  KEITH CRAWLEY	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	76, 79, 82, 87, 90, 92, 94, 96, 204, 208, 209, 691	6/18/06	kc
315	169.1, 169.3	6/18/06	kc

SEARCH NOTES		
Search Notes	Date	Examiner
obtained search from Regina Liang	6/18/06	kc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/KEITH CRAWLEY/ Examiner.Art Unit 2629	
---	--